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**Shin et al.**

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(54) **THIN FILM TRANSISTOR ARRAY PANEL HAVING A PIXEL ELECTRODE INCLUDING A FIRST SUBPIXEL ELECTRODE AND A SECOND SUBPIXEL ELECTRODE CONNECTED TO THE DRAIN ELECTRODE OF THE THIN FILM TRANSISTOR AND A THIRD SUBPIXEL ELECTRODE CAPACITIVELY COUPLED TO A COUPLING ELECTRODE EXTENDED FROM THE DRAIN ELECTRODE**

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(57) **ABSTRACT**

A thin film transistor (TFT) array panel for a Liquid Crystal Display apparatus (LCD) is provided. The TFT array panel comprises a plurality of gate lines, at least one data line intersecting the plurality of gate lines and at least one thin film transistor connected to at least one of the gate lines and the at least one data line. The at least one film transistor comprises a drain electrode. In addition, the TFT array panel further comprises at least one pixel electrode including at least one first subpixel electrode connected to the drain electrode of the thin film transistor and a second subpixel electrode capacitively coupled to the at least one first subpixel electrode. Moreover, the pixel electrode has a partitioning member for partitioning the pixel electrode into at least two partitions having portions which do not overlap the drain electrode. The at least two partitions are disposed symmetrically to a reference line equidistant from the plurality of gate lines.

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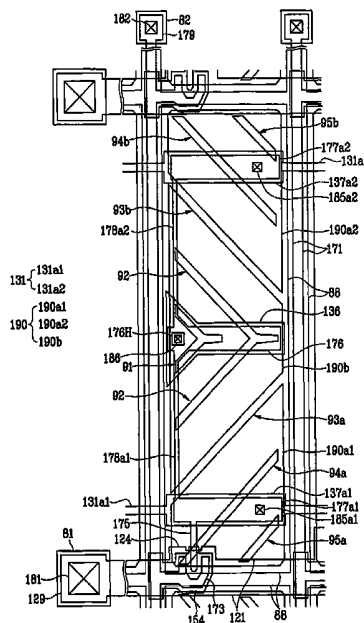
(51) **Int. Cl.**  
**G02F 1/136** (2006.01)  
**G02F 1/1343** (2006.01)

(52) **U.S. Cl.** ..... 349/42; 349/139; 349/142; 349/144

(58) **Field of Classification Search** ..... 349/42,  
349/129, 139-144

See application file for complete search history.

**22 Claims, 8 Drawing Sheets**



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FIG. 1

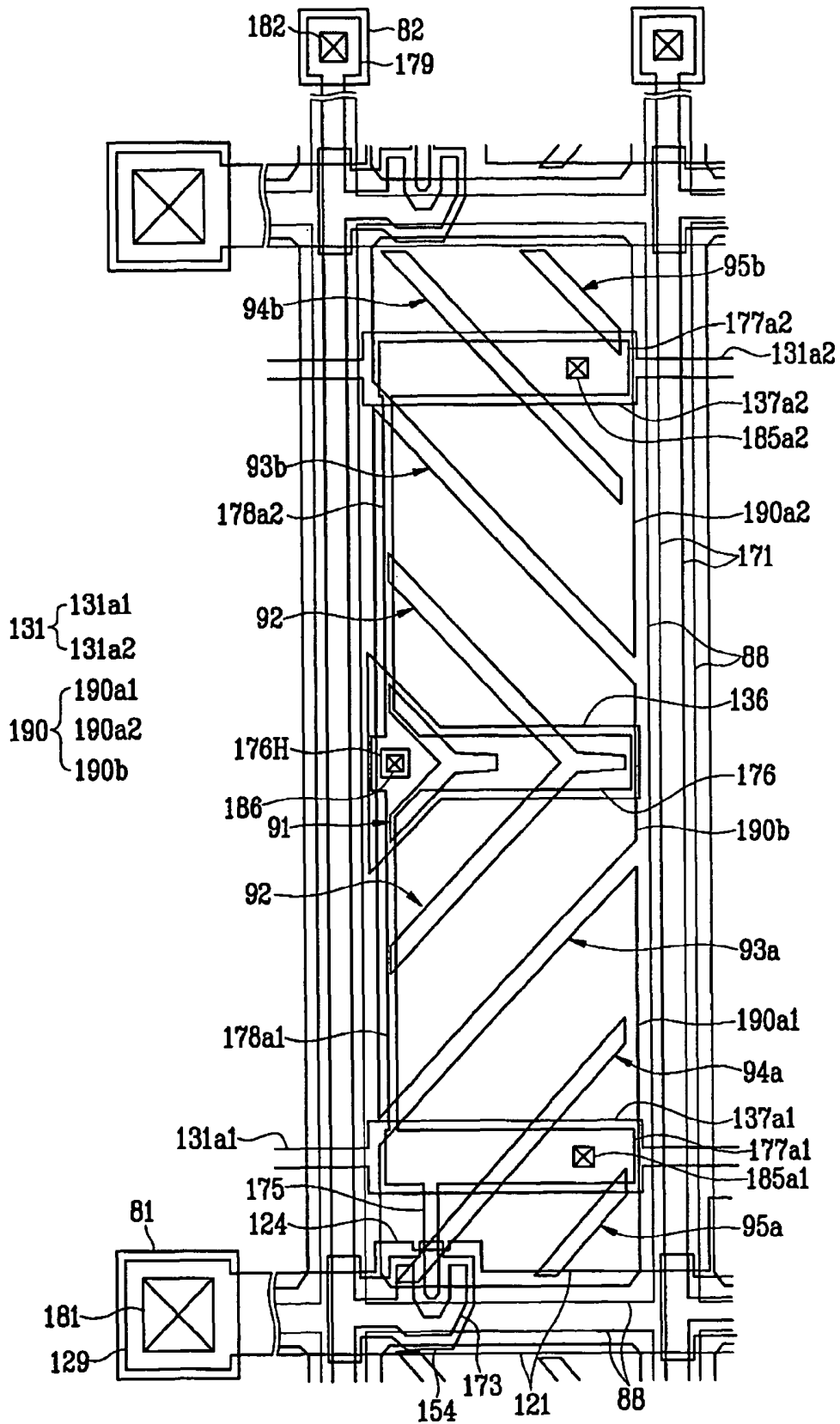


FIG. 2

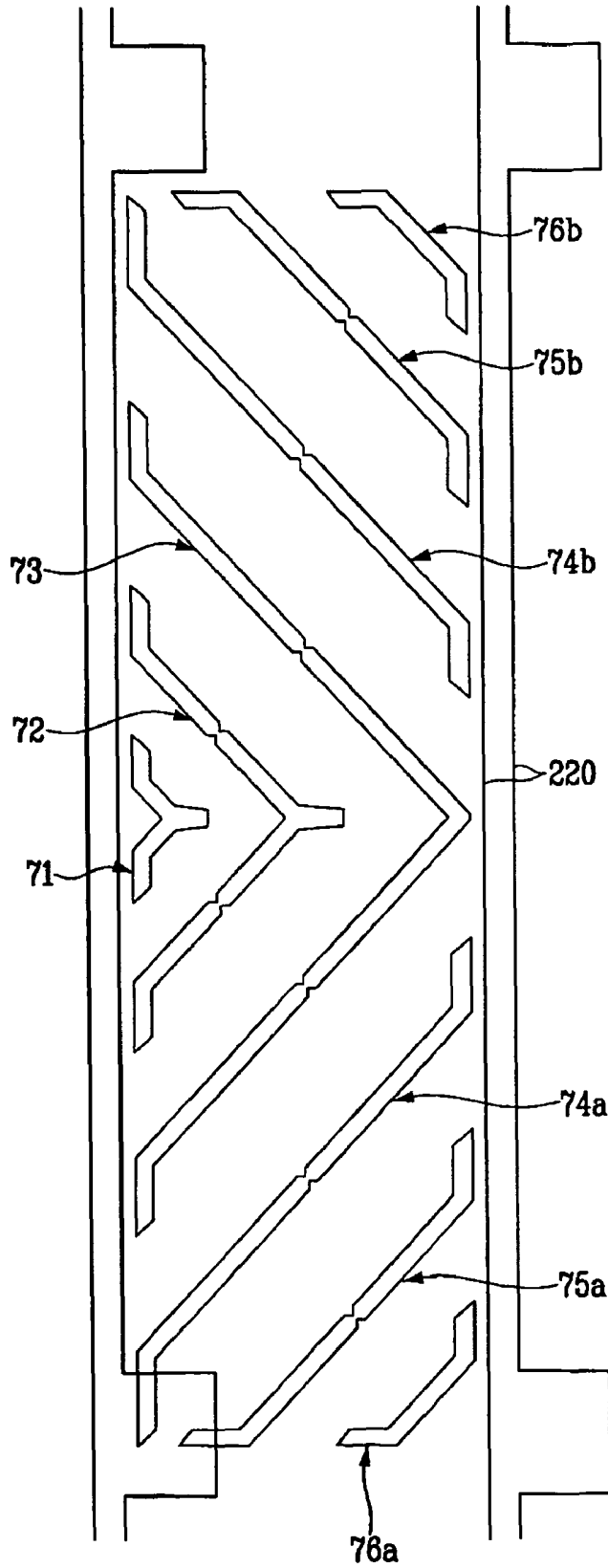


FIG. 3

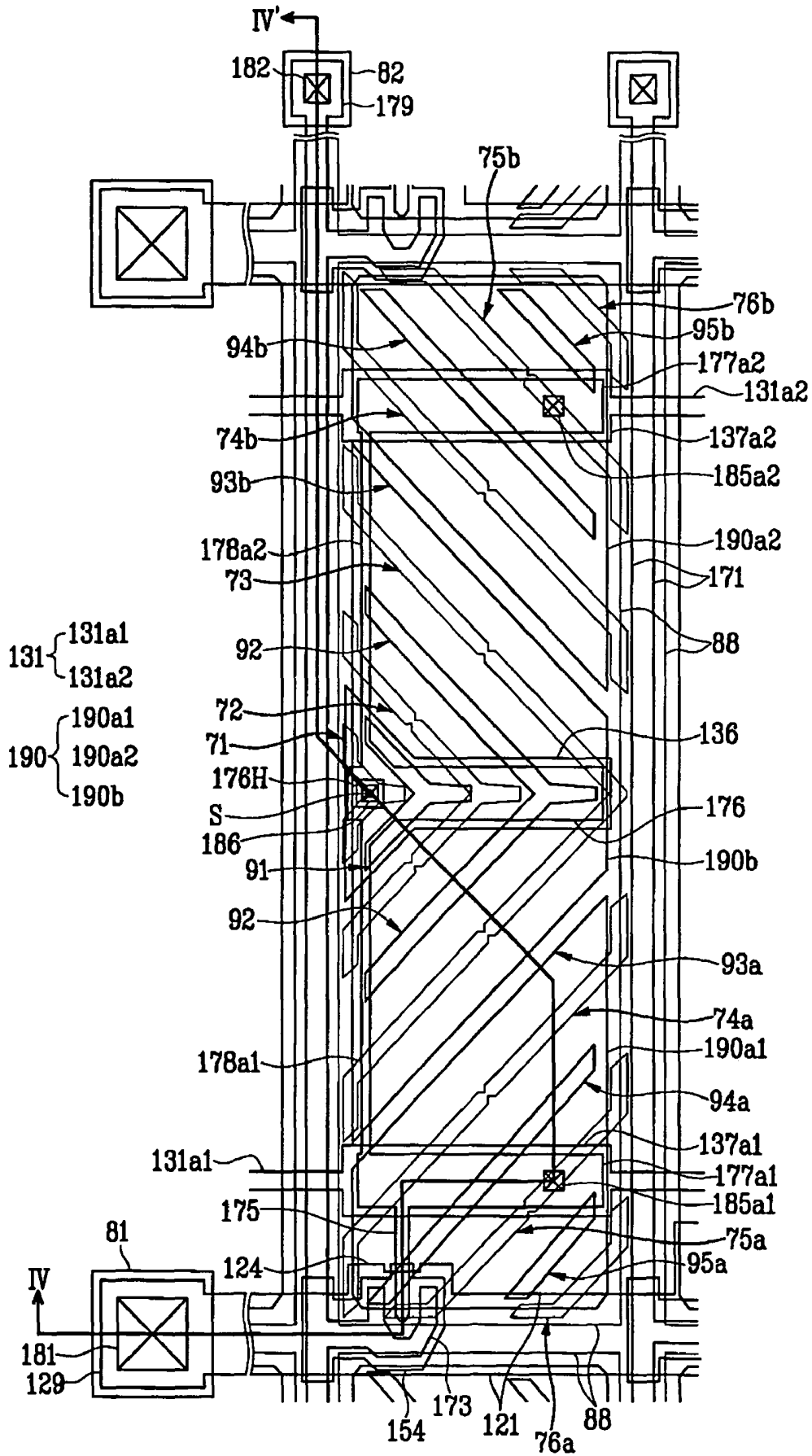




FIG. 5

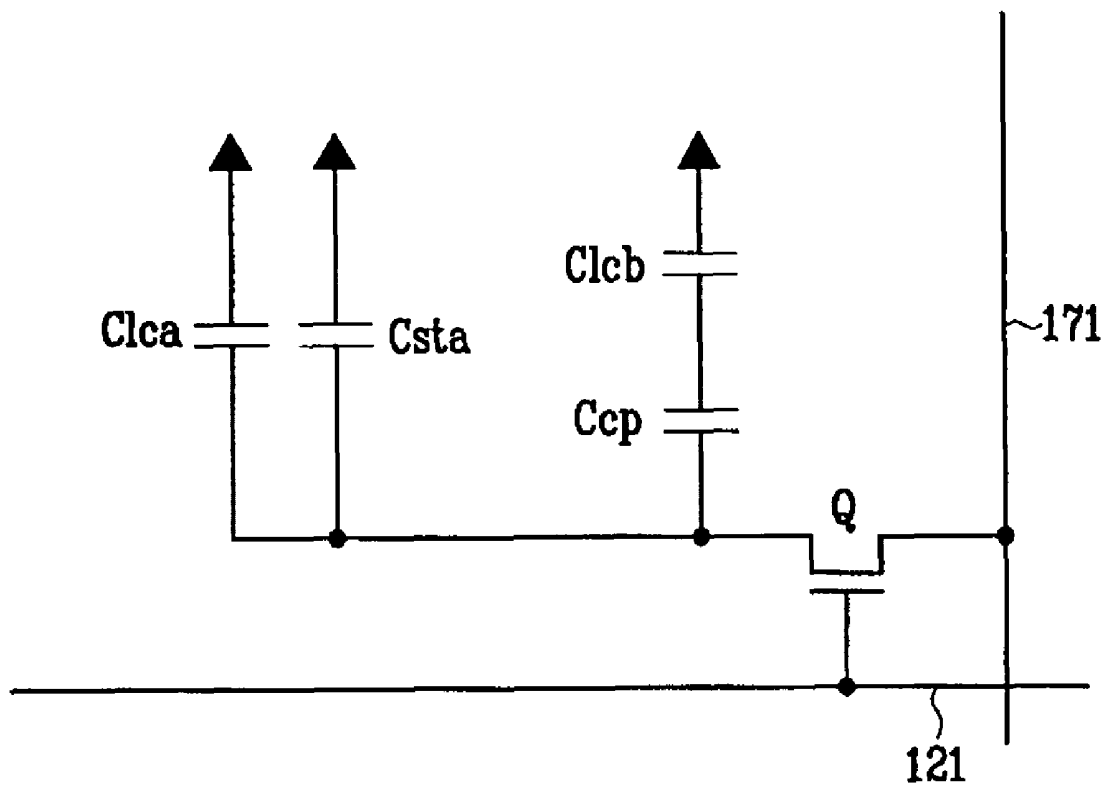


FIG. 6

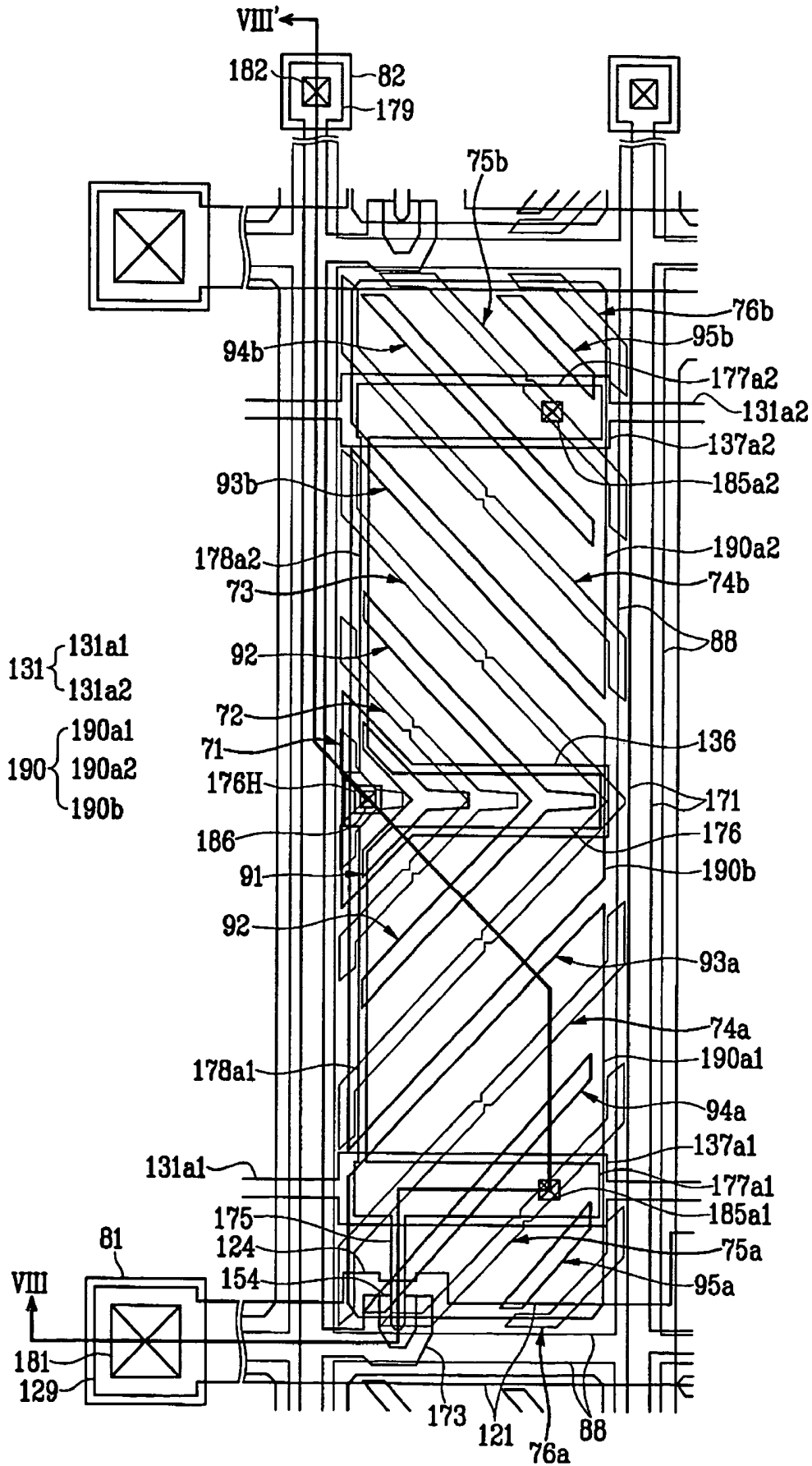


FIG. 7

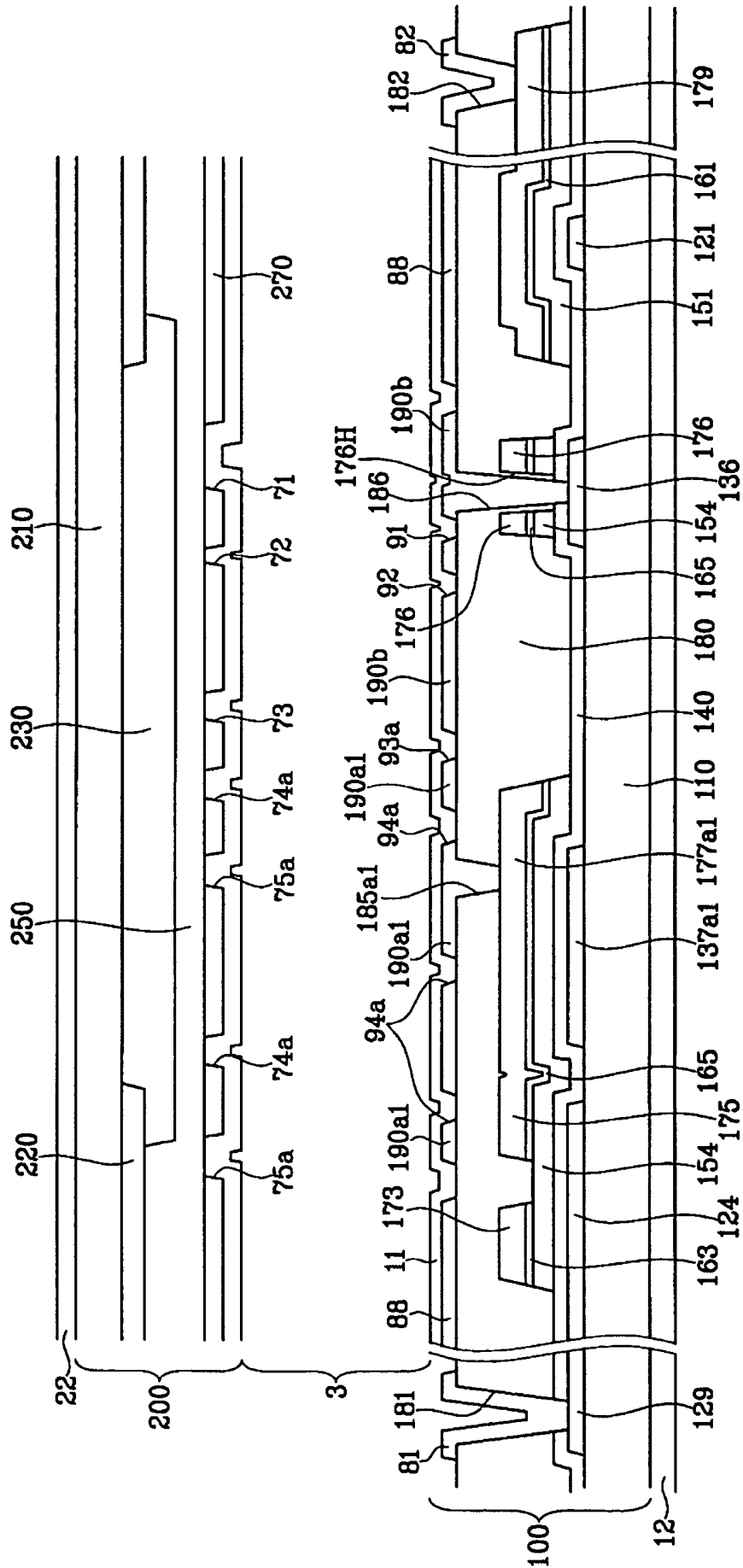
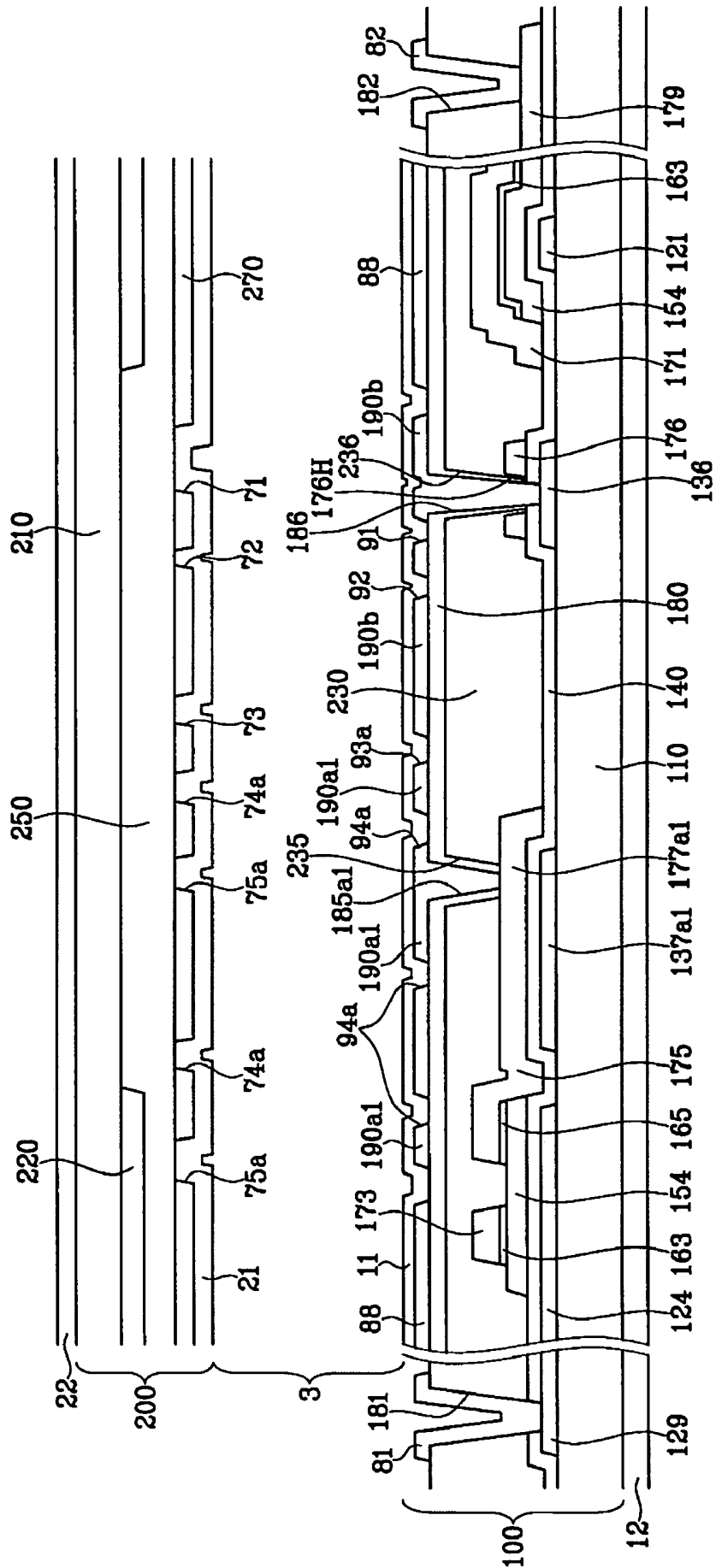


FIG. 8



**THIN FILM TRANSISTOR ARRAY PANEL  
HAVING A PIXEL ELECTRODE INCLUDING  
A FIRST SUBPIXEL ELECTRODE AND A  
SECOND SUBPIXEL ELECTRODE  
CONNECTED TO THE DRAIN ELECTRODE  
OF THE THIN FILM TRANSISTOR AND A  
THIRD SUBPIXEL ELECTRODE  
CAPACITIVELY COUPLED TO A COUPLING  
ELECTRODE EXTENDED FROM THE DRAIN  
ELECTRODE**

CROSS-REFERENCE TO RELATED  
APPLICATION

This application claims priority from Korean Patent Application No. 10-2004-0089246, filed Nov. 4, 2004, the disclosure of which is hereby incorporated by reference herein in its entirety.

BACKGROUND OF THE INVENTION

(a) Field of the Invention

The present invention relates to a thin film transistor (TFT) array panel.

(b) Description of the Related Art

A liquid crystal display apparatus (hereinafter referred to as an LCD) is one of the most widely used flat panel displays. An LCD typically includes two panels provided with field-generating electrodes such as pixel electrodes and a common electrode and a liquid crystal (LC) layer interposed therebetween. The LCD displays images by applying voltages to the field-generating electrodes to generate an electric field in the LC layer, which determines orientations of LC molecules in the LC layer for adjusting polarization of the incident light.

One popular type of LCD, is the vertical alignment (VA) mode LCD, which aligns LC molecules such that the long axes of the LC molecules are perpendicular to the panels in the absence of an electric field. Much attention has been focused on the VA mode LCD because of its high contrast ratio and wide reference viewing angle.

Wide viewing angle of the VA mode LCD can be achieved via cutouts in the field-generating electrodes and protrusions on the field-generating electrodes. The cutouts and the protrusions affect the tilt directions of the LC molecules, e.g., the tilt directions can be distributed into several directions such that the reference viewing angle is widened. However, lateral visibility may not be improved in comparison to front visibility.

SUMMARY OF THE INVENTION

A thin film transistor (TFT) array panel for a Liquid Crystal Display apparatus (LCD) is provided. The TFT array panel comprises a plurality of gate lines, at least one data line intersecting the plurality of gate lines and at least one thin film transistor connected to at least one of the gate lines and the at least one data line. The at least one film transistor comprises a drain electrode. In addition, the TFT array panel further comprises at least one pixel electrode including at least one first subpixel electrode connected to the drain electrode of the thin film transistor and a second subpixel electrode capacitively coupled to the at least one first subpixel electrode. Moreover, the pixel electrode has a partitioning member for partitioning the pixel electrode into at least two partitions having portions which do not overlap the drain electrode. The at least two partitions are disposed symmetrically to a reference line equidistant from the plurality of gate lines.

The at least one first subpixel electrode may be divided into a third subpixel electrode and a fourth subpixel electrode. The drain electrode may include first and second portions connected to the third and the fourth subpixel electrodes, respectively, and disposed substantially symmetrical to the reference line. The thin film array panel may further include first and second storage electrodes overlapping the first and the second portions of the drain electrode, respectively.

The first and the second storage electrodes may be disposed substantially symmetrical to the reference line.

The third and the fourth subpixel electrodes may be disposed opposite each other with respect to the second subpixel electrode and they may be disposed substantially symmetrical to the reference line.

The drain electrode may include an interconnection connecting the first portion and the second portion and the interconnection may be disposed adjacent to the data line and substantially parallel to the data line.

The drain electrode may further include a coupling electrode overlapping the second subpixel electrode, and the thin film array panel may further include a capacitive electrode connected to the second subpixel electrode and overlapping the coupling electrode. The coupling electrode or the capacitive electrode may be disposed substantially symmetrical to the reference line.

The coupling electrode may have a through-hole and the capacitive electrode and the second subpixel electrode may be connected to each other through the through-hole.

The thin film array panel may further include a shielding electrode separated from the pixel electrode and overlapping the data line or the gate line at least in part.

The pixel electrode and the shielding electrode may include the same layer.

The shielding electrode may extend along the data line or the gate lines and may fully cover the data line.

BRIEF DESCRIPTION OF THE DRAWINGS

FIG. 1 is a layout view of a TFT array panel of an LCD according to an exemplary embodiment of the present invention;

FIG. 2 is a layout view of a common electrode panel of an LCD according to an exemplary embodiment of the present invention;

FIG. 3 is a layout view of an LCD including the TFT array panel shown in FIG. 1 and the common electrode panel shown in FIG. 2;

FIG. 4 is a sectional view of the LCD shown in FIG. 3 taken along line IV-IV';

FIG. 5 is an equivalent circuit diagram of the LCD shown in FIGS. 1-4;

FIG. 6 is a layout view of an LCD according to an exemplary embodiment of the present invention;

FIG. 7 is a sectional view of the LCD shown in FIG. 6 taken along line VII-VII'; and

FIG. 8 is a sectional view of the LCD shown in FIG. 3 taken along line IV-IV' according to an exemplary embodiment of the present invention.

DETAILED DESCRIPTION OF THE PREFERRED  
EMBODIMENTS

The exemplary embodiments of the present invention now will be described more fully hereinafter with reference to the accompanying drawings, in which preferred embodiments of the invention are shown. The present invention may, however,

be embodied in many different forms and should not be construed as limited to the embodiments set forth herein.

Like numerals refer to like elements throughout. It will be understood that when an element such as a layer, film, region or substrate is referred to as being "on" another element, it can be directly on the other element or intervening elements may also be present. In contrast, when an element is referred to as being "directly on" another element, there are no intervening elements present.

An LCD according to an exemplary embodiment of the present invention will be described in detail with reference to FIGS. 1-5.

FIG. 1 is a layout view of a TFT array panel of the LCD, FIG. 2 is a layout view of a common electrode panel of an LCD, FIG. 3 is a layout view of the LCD including the TFT array panel shown in FIG. 1 and the common electrode panel shown in FIG. 2, FIG. 4 is a sectional view of the LCD shown in FIG. 3 taken along line IV-IV', and FIG. 5 is an equivalent circuit diagram of the LCD shown in FIGS. 1-4.

Referring to FIGS. 1-4, the LCD according to an exemplary embodiment of the present invention includes a TFT array panel 100, a common electrode panel 200, and a LC layer 3 interposed between the panels 100 and 200.

The TFT array panel 100 is now described in detail with reference FIGS. 1, 3 and 4.

The TFT array panel 100 includes a plurality of gate conductors which include a plurality of gate lines 121, a plurality of storage electrode lines 131, and a plurality of capacitive electrodes 136 formed on an insulating substrate 110, such as a transparent glass or plastic substrate.

The gate lines 121 transmit gate signals and extend substantially in a transverse direction. Each gate line 121 includes a plurality of gate electrodes 124 projecting upwardly and an end portion 129 having an area for contact with another layer or external driving circuit. In addition, a gate driving circuit for generating gate signals may be mounted on a flexible printed circuit (FPC) film. The FPC film may either be attached to the substrate 110, directly mounted on the substrate 110, or integrated onto the substrate 110. The gate lines 121 may in turn be connected to the gate driving circuit on the substrate 110.

The storage electrodes 131 are supplied with a predetermined voltage and each of the storage electrodes 131 includes a pair of lower and upper stems 131a1 and 131a2 extend substantially parallel to the gate lines 121. Moreover, each of the storage electrode lines 131 are disposed between the gate lines 121, with the lower and the upper stems 131a1 and 131a2 being disposed in close proximity to the gate lines 121. The lower and the upper stems 131a1 and 131a2 include lower and upper storage electrodes 137a1 and 137a2, respectively, expanding in upward and downward directions, respectively. It is noted however that the storage electrode lines 131 may have various shapes and arrangements.

Further, each of the capacitive electrodes 136 is rectangularly shaped and elongated parallel with respect to the gate lines 121. The capacitive electrodes 136 are separated from the gate lines 121 and the storage electrode lines 131. Moreover, each of the capacitive electrodes 136 is disposed between the pair of lower and upper storage electrodes 137a1 and 137a2 and are also substantially equidistant from the lower and the upper storage electrodes 137a1 and 137a2 and from the gate lines 121. In addition, each of the capacitive electrodes 136 also includes a funneled left end portion that has oblique or inclined edges which make about a 45 degrees angle with respect to the gate lines 121.

The gate conductors 121, 131 and 136 may be made of various metals or conductors. However, the gate conductors

121, 131 and 136 are preferably made of aluminum (Al) or an Al alloy, silver (Ag) or an Ag alloy, copper (Cu) or a Cu alloy, molybdenum (Mo) or a Mo alloy, chromium (Cr), Tantalum (Ta), or Titanium (Ti). In addition, the gate conductors 121, 131 and 136 may each have a multi-layered structure including two conductive films having different physical characteristics. In the above case, one of the two films is preferably made of a low resistivity metal, such as for example an Al containing metal, a Ag containing metal, or a Cu containing metal for reducing signal delay or voltage drop. The other film is preferably made of a material (e.g. a Mo containing metal, Cr, Ta, or Ti) which has good physical, chemical, and electrical contact characteristics with respect to indium tin oxide (ITO) or indium zinc oxide (IZO), such as for example Mo or Mo alloys, Cr, Ta or Ti. Examples of possible combinations for the two films include but are not limited to a lower Cr film and an upper Al (alloy) film and a lower Al (alloy) film and an upper Mo (alloy) film.

The lateral sides of the gate conductors 121, 131 and 136 are inclined relative to a surface of the substrate 110, with an inclination angle from about 30 to about 80 degrees.

Further, a gate insulating layer 140 preferably made of silicon nitride (SiNx) or silicon oxide (SiOx) is formed on the gate conductors 121, 131 and 136.

A plurality of semiconductor islands 154 preferably made of hydrogenated amorphous silicon (abbreviated to "a-Si") or polysilicon are formed on the gate insulating layer 140. The semiconductor islands 154 are disposed on the gate electrodes 124 and include extensions covering edges of the gate lines 121. A plurality of other semiconductor islands (not shown) may be disposed on the storage electrode lines 131.

A plurality of ohmic contact islands 163 and 165 are formed on the semiconductor islands 154. The ohmic contacts 163 and 165 are preferably made of n+ hydrogenated a-Si, which is heavily doped with n type impurity such as phosphorous. Alternatively, the ohmic contacts 163 and 165 may be made of silicide. The ohmic contacts 163 and 165 are located in pairs on the semiconductor islands 154.

The lateral sides of the semiconductor islands 154 and the ohmic contacts 163 and 165 are inclined relative to the surface of the substrate 110, with an inclination angle preferably in a range of about 30 to about 80 degrees.

A plurality of data conductors including a plurality of data lines 171 and a plurality of drain electrodes 175 are formed on the ohmic contacts 163 and 165 and the gate insulating layer 140.

The data lines 171 transmit data signals and extend substantially in a longitudinal direction to intersect the gate lines 121 and the storage electrode lines 131. Each data line 171 includes a plurality of source electrodes 173 projecting toward the gate electrodes 124 and an end portion 179 having an area for contact with another layer or an external driving circuit. A data driving circuit for generating the data signals may be mounted on a FPC film. The FPC film may be attached to the substrate 110, directly mounted on the substrate 110, or integrated onto the substrate 110. The data lines 171 may in turn be connected to the driving circuit on the substrate 110.

Each of the drain electrodes 175 is separated from the data lines 171 and includes an end portion disposed opposite to the source electrodes 173. The end portion is partly enclosed by a source electrode 173 which is curved like the letter U of the alphabet.

Each drain electrode 175 further includes lower, upper, and central expansions 177a1, 177a2, and 176 and a pair of interconnections 178a1 and 178a2 connecting the expansions 177a1, 177a2, and 176. Each of the expansions 177a1, 177a2, and 176 are rectangularly shaped and are elongated

parallel with respect to the gate lines **121**. Interconnections **178a1** and **178a2** connect the expansions **177a1**, **177a2**, and **176** near left sides thereof and extend substantially parallel to the data lines **171**.

The lower and upper expansions **177a1** and **177a2** overlap lower and upper storage electrodes **137a1** and **137a2**, respectively.

The central expansion **176** overlaps a capacitive electrode **136** to form a "coupling electrode." The coupling electrode which includes central expansion **176** and capacitive electrode **136**, further includes a through-hole **176H** exposing a top surface of the gate insulating layer **140** near a left end portion of the coupling electrode. The through-hole **176H** has substantially the same shape as the capacitive electrode **136**.

A gate electrode **124**, a source electrode **173**, and a drain electrode **175** along with a semiconductor island **154** form a TFT having a channel formed in the semiconductor island **154** disposed between the source electrode **173** and the drain electrode **175**.

The data conductors **171** and **175** may be made of various metals or conductors. However, the data conductors **171** and **175** are preferably made of refractory metal such as Cr, Mo, Ta, Ti, or alloys thereof. In addition, the data conductors **171** and **175** may each have a multilayered structure including a refractory metal film and a low resistivity film. Examples of the multi-layered structure include but are not limited to a double-layered structure including a lower Cr/Mo (alloy) film and an upper Al (alloy) film or a triple-layered structure of a lower Mo (alloy) film, an intermediate Al (alloy) film, and an upper Mo (alloy) film. However, the data conductors **171** and **175** may be made of various metals or conductors.

The data conductors **171** and **175** have inclined edge profiles, with an inclination angle from about 30 to about 80 degrees.

The ohmic contacts **163** and **165** are interposed between the underlying semiconductor islands **154** and the overlying data conductors **171** and **175** thereon and reduce contact resistance therebetween. Extensions of the semiconductor islands **154** disposed on the edges of the gate lines **121** smooth the profile of the surface of these edges of the gate lines **121** to prevent the disconnection of the data lines **171** there. The semiconductor islands **154** include some exposed portions, which are not covered with the data conductors **171** and **175**, such as portions located between the source electrodes **173** and the drain electrodes **175**.

A passivation layer **180** is formed on the data conductors **171** and **175**, and the exposed portions of the semiconductor islands **154**. The passivation layer **180** is preferably made of an inorganic or an organic insulator and may also have a flat surface. Examples of the inorganic insulator include but are not limited to silicon nitride and silicon oxide. The organic insulator may be photosensitive. Moreover, the organic insulator preferably has dielectric constant less than about 4.0. Alternatively, the passivation layer **180** may include a lower film of inorganic insulator and an upper film of organic insulator such that it takes the excellent insulating characteristics of an organic insulator while preventing the exposed portions of the semiconductor islands **154** from being damaged by the organic insulator.

Additionally, the passivation layer **180** has a plurality of contact holes **182** exposing the end portions **179** of the data lines **171** and a plurality of contact holes **185a1** and **185a2** exposing the lower and the upper expansions **177a1** and **177a2** of the drain electrodes **175**, respectively. The passivation layer **180** and the gate insulating layer **140** have a plurality of contact holes **181** exposing the end portions **129** of the gate lines **121** and a plurality of contact holes **186** pen-

etrating the through-holes **176H** and exposing the end portions of the capacitive electrodes **136**. The contact holes **181**, **182**, **185a1**, **185a2** and **186** may have inclined or stepped sidewalls.

A plurality of pixel electrodes **190**, a shielding electrode **88**, and a plurality of contact assistants **81** and **82** are also formed on the passivation layer **180**. They are preferably made of a transparent conductor such as ITO or IZO or reflective conductor such as Ag, Al, Cr, or alloys thereof.

Each pixel electrode **190** is rectangularly shaped or substantially rectangularly shaped and has chamfered corners. The chamfered edges of the pixel electrode **190** make an angle of about 45 degrees with the gate lines **121**. The pixel electrodes **190** overlap the gate lines **121** to increase the aperture ratio.

In addition, each of the pixel electrodes **190** has lower and upper gaps **93a** and **93b** that divide the pixel electrode **190** into lower, upper, and central sub-pixel electrodes **190a1**, **190a2** and **190b**, respectively. The lower and the upper gaps **93a** and **93b** obliquely extend from a left edge to a right edge of the pixel electrode **190** such that the central sub-pixel electrode **190b** resembles an isosceles trapezoid rotated at a right angle with respect to the gate lines **121** and the lower and the upper sub-pixel electrodes **190a1** and **190a2** resemble right-angled trapezoids rotated at a right angle with respect to the gate lines **121**. The lower and the upper gaps **93a** and **93b** are perpendicular to each other and make an angle of about 45 degrees with respect to the gate lines **121**.

The lower and the upper sub-pixel electrodes **190a1** and **190a2** are connected to the lower and the upper expansions **177a1** and **177a2** of the drain electrodes **175** through contact holes **185a1** and **185a2**, respectively.

The central sub-pixel electrode **190b** is connected to a capacitive electrode **136** through a contact hole **186** and overlaps a coupling electrode **176**. The central sub-pixel electrode **190b**, the capacitive electrode **136**, and the coupling electrode **176** form a "coupling capacitor."

The central sub-pixel electrode **190b** has central cutouts **91** and **92**, the lower sub-pixel electrode **190a1** has lower cutouts **94a** and **95a**, and the upper sub-pixel electrode **190a2** has upper cutouts **94b** and **95b**. The cutouts **91**, **92** and **94a-95b** partition the sub-pixel electrodes **190b**, **190a1** and **190a2** into a plurality of partitions. The pixel electrode **190** having the cutouts **91**, **92** and **94a-95b** and the gaps **93a** and **93b** (also referred to as cutouts hereinafter) substantially has an inversion symmetry with respect to a capacitive electrode **136**.

Each of the lower and the upper cutouts **94a-95b** obliquely or slantingly extends to a right edge of the pixel electrode **190** from a left corner, a lower edge, or an upper edge of the pixel electrode **190**. The lower and the upper cutouts **94a-95b** extend substantially perpendicular to each other and make an angle of about 45 degrees with respect to the gate lines **121**.

Each of the center cutouts **91** and **92** includes a transverse portion and a pair of oblique portions connected thereto. The transverse portion extends along the capacitive electrode **136**, and the oblique portions obliquely or slantingly extends from the transverse portion toward the left edge of the pixel electrode **190** parallel to the lower and the upper cutouts **94a-95b**, respectively. The center cutout **91** overlaps the funneled end portion of the coupling electrode **176** and the capacitive electrode **136**.

The number of cutouts or the number of partitions may be varied depending on the design factors such as the size of the pixel electrode **190**, the ratio of the transverse edges and the longitudinal edges of the pixel electrode **190**, the type and characteristics of the liquid crystal layer **3**, etc.

The shielding electrode **88** is supplied with common voltage and it includes longitudinal portions extending along the data lines **171** and transverse portions extending along the gate lines **121** to connect adjacent longitudinal portions. The longitudinal portions fully or substantially cover the data lines **171** entirely, while each of the transverse portions lies within the boundary of the gate line **121**.

The shielding electrode **88** blocks electromagnetic interference between the data lines **171** and the pixel electrodes **190** and between the data lines **171** and the common electrode **270** to reduce the distortion of the voltage of the pixel electrodes **190** and the signal delay of the data voltages carried by the data lines **171**.

The contact assistants **81** and **82** are connected to the end portions **129** of the gate lines **121** and the end portions **179** of the data lines **171** through the contact holes **181** and **182**, respectively. The contact assistants **81** and **82** protect the end portions **129** and **179** and enhance the adhesion between the end portions **129** and **179** and external devices.

The description of the common electrode panel **200** follows with reference to FIGS. **2-4**.

A light blocking member **220**, also referred to as a black matrix herein, for preventing light leakage is formed on an insulating substrate **210**, such as for example a transparent glass or plastic substrate. The light blocking member **220** includes a plurality of rectilinear portions facing the data lines **171** on the TFT array panel **100** and a plurality of widened portions facing the TFTs on the TFT array panel **100**. Also, the light blocking member **220** may have a plurality of through-holes that face the pixel electrodes **190**. In addition, the light blocking member **220** may have substantially the same shape (e.g. planar shape) as the pixel electrodes **190**.

A plurality of color filters **230** are also formed on the substrate **210** and they are disposed substantially in the areas enclosed by the light blocking member **220**. The color filters **230** may extend in a longitudinal direction substantially along the pixel electrodes **190**. The color filters **230** may each represent one of the primary colors such as red, green and blue colors.

An overcoat **250** is formed on the color filters **230** and the light blocking member **220**. The overcoat **250** is preferably made of an (organic) insulator and it prevents the color filters **230** from being exposed and also provides a flat surface.

A common electrode **270** is formed on the overcoat **250**. The common electrode **270** is preferably made of transparent conductive material such as ITO and IZO and has a plurality of cutout sets **71**, **72**, **73**, **74a**, **74b**, **75a**, **75b**, **76a** and **76b**.

Cutout sets **71-76b** face a pixel electrode **190** and include center cutouts **71**, **72** and **73**, lower cutout **74a**, **75a** and **76a** and upper cutouts **74b**, **75b** and **76b**. Cutout **71** is disposed near the contact hole **186**, while each of the other cutouts **72-76b** of the set are disposed between adjacent cutouts **91-95b** of the pixel electrode **190**. Alternatively, each of the cutouts **72-76b** may be disposed between a cutout **95a** or **95b** and a chamfered edge of the pixel electrode **190**. In addition, each of the cutouts **71-76b** has at least an oblique portion extending parallel to the lower cutout **93a-95a** or the upper cutout **93b-95b** of the pixel electrode **190**. Moreover, each of the oblique portions of the cutouts **72-75b** has a depressed notch and the cutouts **71-76b** have substantially an inversion symmetry with respect to a capacitive electrode **136**.

Each of the lower and the upper cutouts **74a-76b** includes an oblique portion and a pair of transverse and a pair of longitudinal portions. The oblique portion extends to a right edge of the pixel electrode **190** from either a left edge, a lower edge, or an upper edge of the pixel electrode **190**. The transverse and longitudinal portions extend from respective ends

of the oblique portion along edges of the pixel electrode **190**, overlapping the edges of the pixel electrode **190**, and making obtuse angles with respect to the oblique portion.

Each of the center cutouts **71** and **72** includes a central transverse portion, a pair of oblique portions, and a pair of terminal longitudinal portions. The center cutout **73** includes a pair of oblique portions and a pair of terminal longitudinal portions. The central transverse portion is disposed near the left edge or the center of the pixel electrode **190** and extends along the capacitive electrode **136**. The oblique portions of the center cutout **73** extend from an end of the central transverse portion or from the center of the right edge of the pixel electrode **190**, located to the left edge of the pixel electrode. The oblique portions of the cutouts **71** and **72** make oblique angles with respect to the central transverse portion. The terminal longitudinal portions extend from the ends of the respective oblique portions along the left edge of the pixel electrode **190**, overlapping the left edge of the pixel electrode **190**, and make obtuse angles with respect to the respective oblique portions.

The number of cutouts **71-76b** may be also varied depending on the design factors. The light blocking member **220** preferably overlaps the cutouts **71-76b** to block the light leakage through the cutouts **71-76b**.

Alignment layers **11** and **21** may be homeotropic and are coated on inner surfaces of the panels **100** and **200**. Polarizers **12** and **22** are provided on outer surfaces of the panels **100** and **200** so that their polarization axes may be crossed and one of the polarization axes may be parallel to the gate lines **121**. One of the polarizers **12** and **22** may be omitted when the LCD is a reflective LCD.

The LCD may further include at least one retardation film for compensating the retardation of the LC layer **3**. The retardation film has birefringence and gives a retardation opposite to that given by the LC layer **3**.

The LCD may further include a backlight unit supplying light to the LC layer **3** through the polarizers **12** and **22**, the retardation film, and the panels **100** and **200**.

It is preferable that the LC layer **3** is in a state of negative dielectric anisotropy. In addition, it is also preferable that the LC layer **3** have been subjected to a vertical alignment in that the LC molecules in the LC layer **3** are aligned such that their long axes are substantially vertical to the surfaces of the panels **100** and **200** in the absence of an electric field. Accordingly, incident light cannot pass the crossed polarization system **12** and **22**.

Opaque members such as the storage electrode lines **131**, the expansions **177a1**, **177a2** and **176**, the interconnections **178a1** and **178a2** of the drain electrodes **175**, and the transparent members such as the pixel electrodes **190** having the cutouts **91-95b** and **71-76b** are symmetrically arranged with respect to the capacitive electrodes **136**. Also, since the interconnections **178a1** and **178a2** are disposed near the edges of the pixel electrodes **190**, they do not decrease the light transmissive areas, but rather block the texture generated near the light transmissive areas.

The LCD according to an exemplary embodiment of the present invention and shown in FIGS. **1-4** is represented as an equivalent circuit shown in FIG. **5**.

Referring to FIG. **5**, a pixel of the LCD includes a TFT **Q**, a first subpixel including a first LC capacitor ( $C_{LCa}$ ) and a storage capacitor ( $C_{ST}$ ), a second subpixel including a second LC capacitor ( $C_{LCb}$ ), and a coupling capacitor ( $C_{cp}$ ).

The first LC capacitor  $C_{LCa}$  includes lower and upper sub-pixel electrodes **190a1** and **190a2** as one terminal, a portion of the common electrode **270** corresponding thereto as the other terminal, and a portion of the LC layer **3** disposed

therebetween as a dielectric. Similarly, the second LC capacitor  $C_{LCb}$  includes a central sub-pixel electrode **190b** as one terminal, a portion of the common electrode **270** corresponding thereto as the other terminal, and a portion of the LC layer **3** disposed thereon as a dielectric.

The storage capacitor  $C_{ST}$  includes lower and upper expansions **177a1** and **177a2** of a drain electrode **175** as one terminal, lower and upper storage electrodes **137a1** and **137a2** as the other terminal, and a portion of the gate insulating layer **140** disposed therebetween as a dielectric. The coupling capacitor  $C_{cp}$  includes a central sub-pixel electrode **190b** and a capacitive electrode **136** as one terminal, a coupling electrode **176** as the other terminal, and portions of the passivation layer **180** and the gate insulating layer **140** disposed therebetween as a dielectric.

The first LC capacitor  $C_{LCa}$  and the storage capacitor  $C_{ST}$  are connected in parallel to a drain of the TFT Q. The coupling capacitor  $C_{cp}$  is connected between the drain of the TFT Q and the second LC capacitor  $C_{LCb}$ . The common electrode **270** is supplied with a common voltage  $V_{com}$  and the storage electrode lines **131** may be supplied with the common voltage  $V_{com}$ .

The TFT Q applies data voltages from data line **171** to the first LC capacitor  $C_{LCa}$  and the coupling capacitor  $C_{cp}$  in response to a gate signal from gate line **121**. The coupling capacitor  $C_{cp}$  transmits the data voltage with a modified magnitude to the second LC capacitor  $C_{LCb}$ .

When the storage electrode line **131** is supplied with the common voltage  $V_{com}$ , the voltage  $V_b$  charged across the second LC capacitor  $C_{LCb}$  is given by:

$$V_b = V_{ax} [C_{cp} / (C_{cp} + C_{LCb})],$$

where  $V_a$  denotes the voltage of the first LC capacitor  $C_{LCa}$ .

Since the term  $C_{cp} / (C_{cp} + C_{LCb})$  is smaller than one, the voltage  $V_b$  of the second LC capacitor  $C_{LCb}$  is less greater than that of the first LC capacitor  $C_{LCa}$ . The above inequality may also occur in the situation wherein the voltage of the storage electrode line **131** does not equal the common voltage  $V_{com}$ .

When the potential difference is generated across the first LC capacitor  $C_{LCa}$  or the second LC capacitor  $C_{LCb}$ , an electric field substantially perpendicular to the surfaces of the panels **100** and **200** is generated in the LC layer **3**. Both the pixel electrode **190** and the common electrode **270** are commonly referred to as field generating electrodes hereinafter. Then, the LC molecules in the LC layer **3** tilt in response to the electric field such that their long axes are perpendicular to the field direction. The degree of the tilt of the LC molecules determines the variation of the polarization of light incident on the LC layer **3**. In turn, the variation of the light polarization is transformed into the variation of the light transmittance by the polarizers **12** and **22**. In this way, the LCD displays images.

The tilt angle of the LC molecules depends on the strength of the electric field. Since the voltage  $V_a$  of the first LC capacitor  $C_{LCa}$  and the voltage  $V_b$  of the second LC capacitor  $C_{LCb}$  are different from each other, the tilt direction of the LC molecules in the first subpixel is different from that in the second subpixel and thus the luminances of the two subpixels are different. Thus, by maintaining the average luminance of the two subpixels in a target luminance, the voltages  $V_a$  and  $V_b$  of the first and the second subpixels can be adjusted so that an image viewed from a lateral side is closer to an image viewed from the front, thereby improving the lateral visibility.

The ratio of the voltages  $V_a$  and  $V_b$  can be adjusted by varying the capacitance of the coupling capacitor  $C_{cp}$ . More-

over, the coupling capacitance  $C_{cp}$  can be varied by changing the overlapping area and distance between the coupling electrode **176** and the central sub-pixel electrode **190b** (and the capacitive electrode **136**). For example, the distance between the coupling electrode **176** and the central sub-pixel electrode **190b** becomes large when the capacitive electrode **136** is removed and the coupling electrode **176** is moved to the position of the capacitive electrode **136**. Preferably, the voltage  $V_b$  of the second LC capacitor  $C_{LCb}$  is from about 0.6 to about 0.8 times the voltage  $V_a$  of the first LC capacitor  $C_{LCa}$ .

The voltage  $V_b$  charged in the second LC capacitor  $C_{LCb}$  may be larger than the voltage  $V_a$  of the first LC capacitor  $C_{LCa}$ . This is achieved by precharging the second LC capacitor  $C_{LCb}$  with a predetermined voltage such as the common voltage  $V_{com}$ .

The ratio between the lower and the upper sub-pixel electrodes **190a1** and **190a2** of the first subpixel and the central sub-pixel electrode **190b** of the second subpixel is preferably from about 1:0.85 to about 1:1.15. In addition, the number of the sub-pixel electrodes in each of the LC capacitors  $C_{LCa}$  and  $C_{LCb}$  may be changed.

The tilt direction of the LC molecules is determined by a horizontal component generated by the cutouts **91-95b** and **71-76b** of the field generating electrodes **190** and **270** and the oblique edges of the pixel electrodes **190** distorting the electric field. The electric field being perpendicular or at least substantially perpendicular to the edges of cutouts **91-95b** and **71-76b** and the oblique edges of the pixel electrodes **190**. Referring to FIG. 3, a set of the cutouts **91-95b** and **71-76b** divides a pixel electrode **190** into a plurality of sub-areas and each sub-area has two major edges. Since the LC molecules on each sub-area tilt perpendicular to the major edges, the azimuthal distribution of the tilt directions are localized to four directions, thereby increasing the reference viewing angle of the LCD.

In addition, when the areas that can transmit light for the above-described four tilt directions are the same, the visibility improves for various viewing directions. Since the opaque members are symmetrically arranged as described above, the adjustment of the transmissive areas is relatively simple.

The notches in the cutouts **72-75b** help determine the tilt directions of the LC molecules on the cutouts **72-75b**. Notches may also be provided in cutouts **91-95b** and may have various shapes and arrangements.

The shapes and the arrangements of the cutouts **91-95b** and **71-76b** for determining the tilt directions of the LC molecules may be modified and at least one of the cutouts **91-95b** and **71-76b** can be substituted with protrusions or depressions. The protrusions are preferably made of organic or inorganic material and disposed on or under the field-generating electrodes **190** or **270**.

Further, since there is no electric field between the shielding electrode **88** and the common electrode **270**, the LC molecules on the shielding electrode **88** remain in their initial orientations and thus the light incident thereon is blocked. In the above situation, the shielding electrode **88** may serve as a light blocking member and the light blocking member **220** may thus be omitted.

An LCD according to an exemplary embodiment of the present invention will be described in detail with reference to FIGS. 6 and 7.

FIG. 6 is a layout view of an LCD according to another exemplary embodiment of the present invention, and FIG. 7 is a sectional view of the LCD shown in FIG. 6 taken along line VII-VII.

Referring to FIGS. 6 and 7, the LCD includes a TFT array panel **100**, a common electrode panel **200**, a LC layer **3**

interposed between the panels 100 and 200, and a pair of polarizers 12 and 22 attached on outer surfaces of the panels 100 and 200.

Layered structures of the panels 100 and 200 according to this exemplary embodiment are virtually the same as those shown in FIGS. 1-4.

Regarding the TFT array panel 100, a plurality of gate lines 121 including gate electrodes 124 and end portions 129, a plurality of storage electrode lines 131 including stems 131a1 and 131a2 and storage electrodes 137a1 and 137a2, and a plurality of capacitive electrodes 136 are formed on a substrate 110. A gate insulating layer 140, a plurality of semiconductors 154, and a plurality of ohmic contacts 163 and 165 are sequentially formed on the gate lines 121 and the storage electrodes lines 131. A plurality of data lines 171 including source electrodes 173 and end portions 179 and a plurality of drain electrodes 175 including expansions 177a1, 177a2 and 176 and interconnections 178a1 and 178a2 are formed on the ohmic contacts 163 and 165. A passivation layer 180 is formed on the data lines 171, the drain electrodes 175, and exposed portions of the semiconductors 154. A plurality of contact holes 181, 182, 185a1, 185a2 and 186 are provided at the passivation layer 180 and the gate insulating layer 140. The contact holes 186 pass through through-holes 176H provided at the expansions 176 of the drain electrodes 175. Additionally, a plurality of pixel electrodes 190 including subpixel electrodes 190a1, 190a2 and 190b with cutouts 91-95b, a shielding electrode 88, and a plurality of contact assistants 81 and 82 are formed on the passivation layer 180, with an alignment layer 11 being coated thereon.

Regarding the common electrode panel 200, a light blocking member 220, a plurality of color filters 230, an overcoat 250, a common electrode 270 having cutouts 71-76b, and an alignment layer 21 are formed on an insulating substrate 210.

In contrast to the LCD shown in FIGS. 1-4, the semiconductors 154 and the ohmic contacts 163 of the TFT array panel 100 according to this exemplary embodiment extend along the data lines 171 to form semiconductor stripes 151 and ohmic contact stripes 161. In addition, the semiconductor stripes 151 have substantially the same shapes (e.g. planar shapes) as the data lines 171 and the drain electrodes 175, as well as the underlying ohmic contacts 163 and 165. Moreover, the semiconductors 154 include some exposed portions, which are not covered with the data lines 171 and the drain electrodes 175, such as portions located between the source electrodes 173 and the drain electrodes 175.

A manufacturing method of the TFT array panel according to an exemplary embodiment simultaneously forms the data lines 171 and the drain electrodes 175, the semiconductors 151, and the ohmic contacts 161 and 165 using one photolithography step.

A photoresist masking pattern for the photolithography process has position-dependent thickness, and in particular, it has thicker portions and thinner portions. The thicker portions are located on wire areas that will be occupied by the data lines 171 and the drain electrodes 175, and the thinner portions are located on channel areas of TFTs.

The position-dependent thickness of the photoresist may be obtained using several techniques. For example, by providing translucent areas on the exposure mask as well as transparent areas and light blocking opaque areas. The translucent areas may have a slit pattern, a lattice pattern, a thin film(s) with intermediate transmittance or intermediate thickness. When using a slit pattern, it is preferable that the width of the slits or the distance between the slits is smaller than the resolution of a light exposer used for the photolithography. Another example is to use reflowable photoresist. For

instance, once a photoresist pattern made of a reflowable material is formed using only a normal exposure mask to have transparent areas and opaque areas. The above photoresist pattern is then subjected to a reflow process without use of a photoresist to form certain thin portions of the TFT array panel.

Thus, the above manufacturing process is simpler than conventional processes due to the omission of the photolithography step.

Many of the above-described features of the LCD shown in FIGS. 1-4 may be appropriate to the LCD shown in FIGS. 6 and 7.

An LCD according to another exemplary embodiment of the present invention will be described in detail with reference to FIG. 8.

FIG. 8 is a sectional view of the LCD shown in FIG. 3 taken along line IV-IV'.

Referring to FIG. 8, the LCD includes a TFT array panel 100, a common electrode panel 200, a LC layer 3 interposed between the panels 100 and 200, and a pair of polarizers 12 and 22 attached on outer surfaces of the panels 100 and 200.

Layered structures of the panels 100 and 200 according to this exemplary embodiment are virtually the same as those shown in FIGS. 1-4.

Regarding the TFT array panel 100, a plurality of gate lines 121 including gate electrodes 124 and end portions 129, a plurality of storage electrode lines 131 including stems 131a1 and 131a2 and storage electrodes 137a1 and 137a2, and a plurality of capacitive electrodes 136 are formed on a substrate 110. A gate insulating layer 140, a plurality of semiconductors 154, and a plurality of ohmic contacts 163 and 165 are sequentially formed on the gate lines 121 and the storage electrodes lines 131. A plurality of data lines 171 including source electrodes 173 and end portions 179 and a plurality of drain electrodes 175 including expansions 177a1, 177a2 and 176 and interconnections 178a1 and 178a2 are formed on the ohmic contacts 163 and 165 and the gate insulating layer 140. A passivation layer 180 is formed on the data lines 171, the drain electrodes 175, and exposed portions of the semiconductors 154. A plurality of contact holes 181, 182, 185a1, 185a2 and 186 are provided at the passivation layer 180 and the gate insulating layer 140. The contact holes 186 pass through through-holes 176H provided at the expansions 176 of the drain electrodes 175. Also, a plurality of pixel electrodes 190 including subpixel electrodes 190a1, 190a2 and 190b and having cutouts 91-95b, a shielding electrode 88, and a plurality of contact assistants 81 and 82 are formed on the passivation layer 180 with an alignment layer 11 being coated thereon.

Regarding the common electrode panel 200, a light blocking member 220, an overcoat 250, a common electrode 270 having cutouts 71-76b, and an alignment layer 21 are formed on an insulating substrate 210.

In contrast to the LCD shown in FIGS. 1-4, the TFT array panel 100 includes a plurality of color filters 230 disposed under the passivation layer 180, while the common electrode panel 200 has no color filter. In this case, the overcoat 250 may be removed from the common electrode panel 200.

The color filters 230 are disposed between two adjacent data lines 171 and they have a plurality of through-holes 235 and 236 through which the contact holes 185 and 186 pass through, respectively. The color filters 230 are not provided on peripheral areas of the end portions 129 and 179 of the signal lines 121 and 171.

The color filters 230 may extend along a longitudinal direction to form stripes. The color filters 230 may overlap each other to block light leakage between the pixel electrodes 190,

or alternatively may be spaced apart from each other. When the color filters **230** overlap each other, linear portions of the light blocking member **220** may be omitted and in this case, the shielding electrode **88** may cover edges of the color filters **230**. Overlapping portions of the color filters **230** may also have a reduced thickness to decrease the height difference between the overlapping portions.

The color filters **230** may be disposed on the passivation layer **180**, or the passivation layer **180** may be omitted.

Many of the above-described features of the LCD shown in FIGS. **1-4** are also appropriate for the LCD shown in FIG. **8**.

Having described the exemplary embodiments of the present invention, it is further noted that it is readily apparent to those of reasonable skill on the art that various modifications can be made without departing from the spirit and scope of the present invention which is defined by the metes and bounds of the appended claims.

What is claimed is:

**1.** A thin film transistor array panel for a Liquid Crystal Display apparatus (LCD) comprising:

a gate line;

a data line intersecting the gate line;

a thin film transistor connected to the gate line and the data line and including a drain electrode; and

a pixel electrode including a first subpixel electrode and a second subpixel electrode connected to the drain electrode of the thin film transistor and a third subpixel electrode capacitively coupled to a coupling electrode extended from the drain electrode,

wherein the drain electrode comprises a first drain electrode and a second drain electrode,

wherein the first subpixel electrode is directly connected to the first drain electrode and the second subpixel electrode is directly connected to the second drain electrode, and

wherein the first subpixel electrode and the second subpixel electrode are disposed opposite to each other with respect to the third subpixel electrode.

**2.** The thin film array panel of claim **1**, wherein the pixel electrode has a partitioning member for partitioning the pixel electrode into at least two partitions, and the at least two partitions having portions which do not overlap the drain electrode and are disposed substantially symmetrical to a reference line equidistant from adjacent gate lines.

**3.** The thin film array panel of claim **1**, wherein the first drain electrode and the second drain electrode are disposed substantially symmetrical to a reference line equidistant from adjacent two gate lines.

**4.** The thin film array panel of claim **3**, further comprising first and second storage electrodes overlapping the first drain electrode and the second drain electrode, respectively.

**5.** The thin film array panel of claim **4**, wherein the first and the second storage electrodes are disposed substantially symmetrical to the reference line.

**6.** The thin film array panel of claim **3**, wherein the first subpixel electrode and the second subpixel electrode are disposed substantially symmetrical to the reference line.

**7.** The thin film array panel of claim **3**, wherein the drain electrode comprises an interconnection connecting the first drain electrode and the second drain electrode.

**8.** The thin film array panel of claim **7**, wherein the interconnection is disposed adjacent to the data line and substantially parallel to the data line.

**9.** The thin film array panel of claim **3**, wherein the coupling electrode overlaps the third subpixel electrode.

**10.** The thin film array panel of claim **9**, further comprising a capacitive electrode connected to the third subpixel electrode and overlapping the coupling electrode.

**11.** The thin film array panel of claim **10**, wherein the coupling electrode or the capacitive electrode is disposed substantially symmetrical to the reference line.

**12.** The thin film array panel of claim **10**, wherein the coupling electrode has a through-hole and wherein the capacitive electrode and the third subpixel electrode are connected to each other through the through-hole.

**13.** The thin film array panel of claim **1**, further comprising a shielding electrode separated from the pixel electrode and overlapping the data line at least in part.

**14.** The thin film array panel of claim **13**, wherein the pixel electrode and the shielding electrode comprise the same layer.

**15.** The thin film array panel of claim **13**, wherein the shielding electrode extends along the data line or the gate line.

**16.** The thin film array panel of claim **15**, wherein the shielding electrode substantially covers the entire data line.

**17.** The thin film array panel of claim **1**, further comprising a shielding electrode separated from the pixel electrode and overlapping the gate line at least in part.

**18.** A thin film transistor (TFT) array panel for use in a Liquid Crystal Display (LCD) apparatus, comprising:

a plurality of gate lines having gate electrodes and end portions;

a plurality of storage electrode lines, a plurality of storage electrodes, and a plurality of capacitive electrodes disposed on a TFT panel substrate;

a plurality of data lines having source electrodes and end portions and which intersect the plurality of gate lines, a plurality of thin film transistors having a plurality of drain electrodes and said thin film transistors being connected to each of the plurality of gate lines and data lines, said plurality of drain electrodes each having a plurality of expansions and a plurality of interconnections connecting the plurality of expansions together;

a plurality of pixel electrodes divided into a plurality of sub-pixel electrodes by a plurality of gaps, each of said sub-pixels having a plurality of cutouts, each of said pixel electrodes overlap said gate lines, said cutouts partition each of the sub-pixel electrodes into a plurality of partitions,

wherein said storage electrode lines, said expansions and said interconnections of the drain electrodes, and said plurality of pixel electrodes having the plurality of gaps are symmetrically arranged with respect to the capacitive electrodes, and

wherein the capacitive electrodes are formed of a same material and a same layer as the plurality of storage electrodes and wherein the capacitive electrodes are spaced apart from the storage electrodes.

**19.** The thin film transistor array panel of claim **18**, further comprising a plurality of color filters operatively connected to said thin film transistor array panel.

**20.** The thin film transistor array panel of claim **19**, wherein each of the plurality of color filters represent one of the following colors comprising red, green or blue.

**21.** A thin film transistor array panel for a Liquid Crystal Display apparatus (LCD) comprising:

a gate line;

a data line intersecting the gate line;

a thin film transistor connected to the gate line and the data line and including a drain electrode, the drain electrode comprising a first drain electrode and a second drain electrode;

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a pixel electrode including a first subpixel electrode and a second subpixel electrode connected to the drain electrode of the thin film transistor and a third subpixel electrode capacitively coupled to a coupling electrode extended from the drain electrode; and  
a storage electrode comprising:  
a first storage electrode; and  
a second storage electrode disposed substantially symmetrical to a reference line equidistant from adjacent two gate lines,  
wherein the first subpixel electrode and the second subpixel electrode are disposed opposite to each other with respect to the third subpixel electrode and,

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wherein the drain electrode comprises a first drain electrode and a second drain electrode, wherein the first subpixel electrode is directly connected to the first drain electrode and the second subpixel electrode is directly connected to the second drain electrode, and wherein the first drain electrode and the second drain electrode overlap the first storage electrode and the second storage electrode, respectively.

22. The thin film transistor array panel of claim 18, wherein the expansions include an upper expansion, a lower expansion and a central expansion and the central expansions are the coupling electrodes.

\* \* \* \* \*

专利名称(译)	具有像素电极的薄膜晶体管阵列面板，所述像素电极包括连接到所述薄膜晶体管的漏电极的第一子像素电极和第二子像素电极以及电容性地耦合到从所述漏电极延伸的耦合电极的第三子像素电极		
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摘要(译)

提供一种用于液晶显示装置 (LCD) 的薄膜晶体管 (TFT) 阵列面板。TFT阵列面板包括多条栅极线，与多条栅极线交叉的至少一条数据线和连接到栅极线和至少一条数据线中的至少一条的至少一个薄膜晶体管。至少一个薄膜晶体管包括漏电极。另外，TFT阵列面板还包括至少一个像素电极，该像素电极包括连接到薄膜晶体管的漏电极的至少一个第一子像素电极和电容性地耦合到至少一个第一子像素电极的第二子像素电极。此外，像素电极具有分隔构件，用于将像素电极分隔成至少两个分区，该分区具有不与漏电极重叠的部分。至少两个分区对称于与多条栅极线等距的参考线对称设置。

